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DS10BR150 1.0 Gbps LVDS Buffer / Repeater

Check for Samples: DS10BR150

FEATURES

- DC 1.0 Gbps Low Jitter, High Noise Immunity, Low Power Operation
- On-chip 100Ω Input and Output Termination Minimizes Insertion and Return Losses, Reduces Component Count and Minimizes Board Space
- 7 kV ESD on LVDS I/O Pins Protects Adjoining Components
- Small 3 mm x 3 mm 8-WSON Space Saving Package

APPLICATIONS

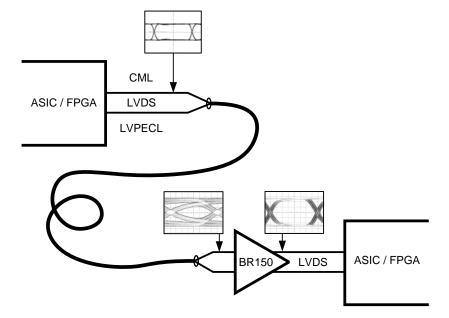
- Clock and Data Buffering
- OC-12 / STM-4
- FireWire 800

Typical Application

DESCRIPTION

The DS10BR150 is a single channel 1.0 Gbps LVDS buffer optimized for high-speed signal transmission over lossy FR-4 printed circuit board backplanes and balanced cables. Fully differential signal paths ensure exceptional signal integrity and noise immunity.

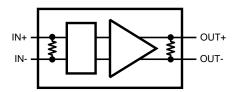
Wide input common mode range allows the receiver to accept signals with LVDS, CML and LVPECL levels; the output levels are LVDS. A very small package footprint requires a minimal space on the board while the flow-through pinout allows easy board layout. The differential inputs and outputs are internally terminated with a 100Ω resistor to lower device input and output return losses, reduce component count and further minimize board space.



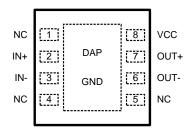
Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



Block Diagram



Pin Diagram



DS10BR150 See Package Number NGQ0008A

PIN DESCRIPTIONS

Pin Name	Pin Name	Pin Type	Pin Description	
NC	1	NA	"NO CONNECT" pin.	
IN+	2	Input	Non-inverting LVDS input pin.	
IN-	3	Input	Inverting LVDS input pin.	
NC	4	NA	"NO CONNECT" pin.	
NC	5	NA	"NO CONNECT" pin.	
OUT-	6	Output	Inverting LVDS output pin.	
OUT+	7	Output	Non-inverting LVDS Output pin.	
VCC	8	Power	Power supply pin.	
GND	DAP	Power	Ground pad (DAP - die attach pad)	





These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

Absolute Maximum Ratings (1)(2)

Absolute maximum ratings	
Supply Voltage (V _{CC})	-0.3V to +4V
LVDS Input Voltage (IN+, IN-)	-0.3V to +4V
Differential Input Voltage VID	1V
LVDS Output Voltage (OUT+, OUT-)	-0.3V to (V _{CC} +0.3V)
LVDS Differential Output Voltage ((OUT+) - (OUT-))	0V to 1V
LVDS Output Short Circuit Current Duration	5 ms
Junction Temperature	+150°C
Storage Temperature Range	−65°C to +150°C
Lead Temperature Range	
Soldering (4 sec.)	+260°C
Maximum Package Power Dissipation at 25°C	
NGQ Package	2.08W
Derate NGQ Package	16.7 mW/°C above +25°C
Package Thermal Resistance	
θ_{JA}	+60.0°C/W
θ _{JC}	+12.3°C/W
ESD Susceptibility	
HBM ⁽³⁾	≥7 kV
MM ⁽⁴⁾	≥250V
CDM ⁽⁵⁾	≥1250V

- (1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur, including inoperability and degradation of device reliability and/or performance. Functional operation of the device and/or non-degradation at the Absolute Maximum Ratings or other conditions beyond those indicated in the Recommended Operating Conditions is not implied. The Recommended Operating Conditions indicate conditions at which the device is functional and the device should not be operated beyond such conditions.
- (2) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and specifications.
- (3) Human Body Model, applicable std. JESD22-A114C
- (4) Machine Model, applicable std. JESD22-A115-A
- (5) Field Induced Charge Device Model, applicable std. JESD22-C101-C

Recommended Operating Conditions

	Min	Тур	Max	Units
Supply Voltage (V _{CC})	3.0	3.3	3.6	V
Receiver Differential Input Voltage (V _{ID})	0		1	V
Operating Free Air Temperature (T _A)	-40	+25	+85	°C

Product Folder Links: DS10BR150



DC Electrical Characteristics

Over recommended operating supply and temperature ranges unless otherwise specified. (1)(2)(3)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
LVDS O	UTPUT DC SPECIFICATIONS (OUT+, OUT-)		•			-
V _{OD}	Differential Output Voltage		250	350	450	mV
ΔV_{OD}	Change in Magnitude of V _{OD} for Complimentary Output States	$R_L = 100\Omega$	-35		35	mV
Vos	Offset Voltage		1.05	1.2	1.375	V
ΔV _{OS}	Change in Magnitude of V _{OS} for Complimentary Output States	$R_L = 100\Omega$	-35		35	mV
Ios	Output Short Circuit Current (4)	OUT to GND		-30	-50	mA
		OUT to V _{CC}		7.5	50	mA
C _{OUT}	Output Capacitance	Any LVDS Output Pin to GND		1.2		pF
R _{OUT}	Output Termination Resistor	Between OUT+ and OUT- Pins		100		Ω
	IPUT DC SPECIFICATIONS (IN+, IN-)		<u> </u>			
V _{ID}	Input Differential Voltage		0		1	V
V _{TH}	Differential Input High Threshold	$V_{CM} = +0.05V \text{ or } V_{CC}-0.05V$		0	+100	mV
V _{TL}	Differential Input Low Threshold		-100	0		mV
V_{CMR}	Common Mode Voltage Range	V _{ID} = 100 mV	0.05		V _{CC} - 0.05	V
I _{IN}	Input Current	V _{IN} = 3.6V or 0V V _{CC} = 3.6V or 0V		±1	±10	μA
C _{IN}	Input Capacitance			1.7		pF
R _{IN}	Input Termination Resistor	Between IN+ and IN- Pins		100		Ω
SUPPLY	CURRENT					
I _{CCD}	Total Supply Current			16	21	mA

⁽¹⁾ The Electrical Characteristics tables list ensured specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not ensured.

⁽²⁾ Current into device pins is defined as positive. Current out of device pins is defined as negative. All voltages are referenced to ground except V_{OD} and ΔV_{OD}.

⁽³⁾ Typical values represent most likely parametric norms for V_{CC} = +3.3V and T_A = +25°C, and at the Recommended Operation Conditions at the time of product characterization and are not ensured.

⁽⁴⁾ Output short circuit current (I_{OS}) is specified as magnitude only, minus sign indicates direction only.



AC Electrical Characteristics (1)

Over recommended operating supply and temperature ranges unless otherwise specified. (2)(3)

Symbol	Parameter	Conditions			Тур	Max	Units
LVDS OUT	PUT AC SPECIFICATIONS (OUT+, OUT-)						
t _{PHLD2}	Differential Propagation Delay High to Low	D 1000			380	600	ps
t _{PLHD2}	Differential Propagation Delay Low to High	$R_L = 100\Omega$	X ^L = 10022			600	ps
t _{SKD1}	Pulse Skew t _{PLHD} - t _{PHLD} (4)				30	150	ps
t _{SKD2}	Part to Part Skew (5)				45	160	ps
t _{LHT}	Rise Time	D 1000			165	400	ps
t _{HLT}	Fall Time	$R_L = 100\Omega$		155	400	ps	
JITTER PE	RFORMANCE Figure 5						
t _{DJ}	Deterministic Jitter (Peak-to-Peak Value) (See	V _{ID} = 350 mV	622 Mbps		12	39	ps
	(6))	$V_{CM} = 1.2V$ K28.5 (NRZ)	1.06 Gbps		15	42	ps
t _{RJ}	Random Jitter (RMS Value) (7)	V _{ID} = 350 mV	311 MHz		0.6	1.3	ps
		V _{CM} = 1.2V Clock (NRZ)	503 MHz		0.6	1.1	ps
t _{TJ}	Total Jitter (Peak to Peak Value) (8)	V _{ID} = 350 mV	622 Mbps		0.02	0.04	UI _{P-P}
		V _{CM} = 1.2V PRBS-23 (NRZ)	1.06 Gbps		0.02	0.05	UI _{P-P}

- (1) Specification is ensured by characterization and is not tested in production.
- (2) The Electrical Characteristics tables list ensured specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not ensured.
- (3) Typical values represent most likely parametric norms for $V_{CC} = +3.3V$ and $T_A = +25^{\circ}C$, and at the Recommended Operation Conditions at the time of product characterization and are not ensured.
- (4) t_{SKD1}, |t_{PLHD} t_{PHLD}|, is the magnitude difference in differential propagation delay time between the positive going edge and the negative going edge of the same channel.
- (5) t_{SKD2} , Part to Part Skew, is defined as the difference between the minimum and maximum specified differential propagation delays. This specification applies to devices at the same V_{CC} and within 5°C of each other within the operating temperature range.
- (6) Tested with a combination of the 1100000101 (K28.5+ character) and 0011111010 (K28.5- character) patterns. Input stimulus jitter is subtracted algebraically.
- (7) Measured on a clock edge with a histogram and an accumulation of 1500 histogram hits. Input stimulus jitter is subtracted geometrically.
- (8) Measured on an eye diagram with a histogram and an accumulation of 3500 histogram hits. Input stimulus jitter is subtracted.



DC Test Circuits

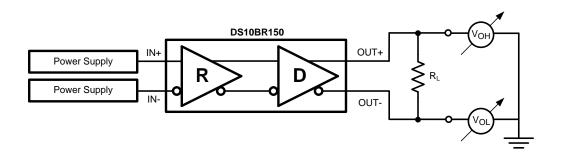


Figure 1. Differential Driver DC Test Circuit

AC Test Circuits and Timing Diagrams

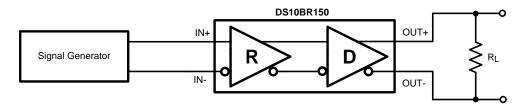


Figure 2. Differential Driver AC Test Circuit

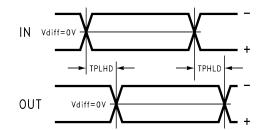


Figure 3. Propagation Delay Timing Diagram

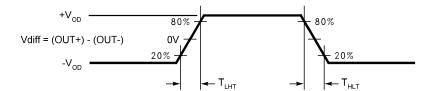


Figure 4. LVDS Output Transition Times



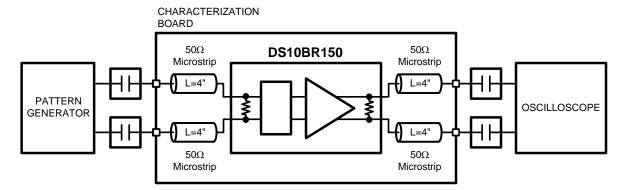


Figure 5. Jitter Measurements Test Circuit

DEVICE OPERATION

INPUT INTERFACING

The DS10BR150 accepts differential signals and allows simple AC or DC coupling. With a wide common mode range, the DS10BR150 can be DC-coupled with all common differential drivers (i.e. LVPECL, LVDS, CML). The following three figures illustrate typical DC-coupled interface to common differential drivers. Note that the DS10BR150 inputs are internally terminated with a 100Ω resistor.

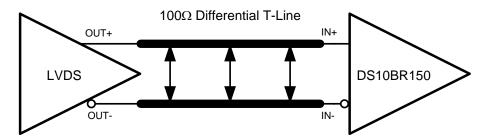


Figure 6. Typical LVDS Driver DC-Coupled Interface to DS10BR150 Input

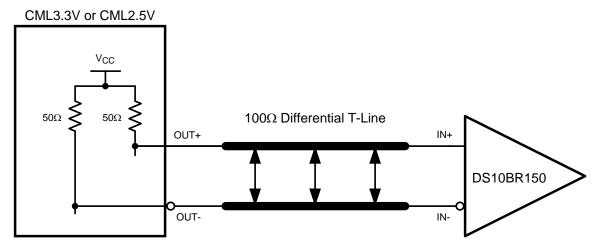


Figure 7. Typical CML Driver DC-Coupled Interface to DS10BR150 Input



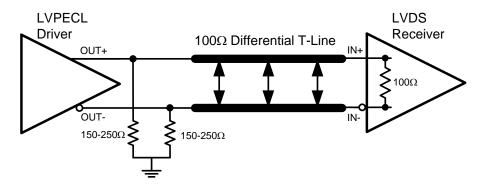


Figure 8. Typical LVPECL Driver DC-Coupled Interface to DS10BR150 Input

OUTPUT INTERFACING

The DS10BR150 outputs signals are compliant to the LVDS standard. It can be DC-coupled to most common differential receivers. The following figure illustrates typical DC-coupled interface to common differential receivers and assumes that the receivers have high impedance inputs. While most differential receivers have a common mode input range that can accommodate LVDS compliant signals, it is recommended to check respective receiver's data sheet prior to implementing the suggested interface implementation.

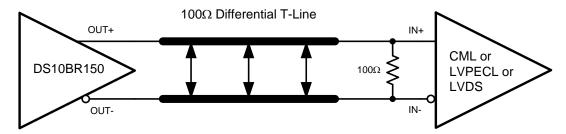
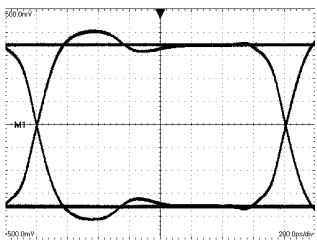


Figure 9. Typical DS10BR150 Output DC-Coupled Interface to an LVDS, CML or LVPECL Receiver



Typical Performance



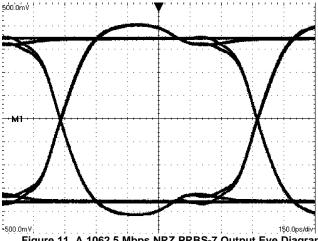
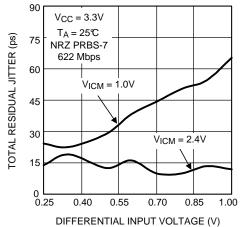
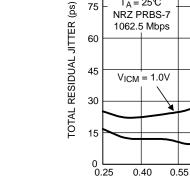


Figure 10. A 622 Mbps NRZ PRBS-7 Output Eye Diagram V:100 mV / DIV, H:200 ps / DIV

Figure 11. A 1062.5 Mbps NRZ PRBS-7 Output Eye Diagram V:100 mV / DIV, H:150 ps / DIV





90

75

60

45

30

 $V_{CC} = 3.3V$

T_A = 25℃ NRZ PRBS-7

1062.5 Mbps

 $V_{ICM} = 1.0V$

Figure 12. Total Jitter as a Function of Input Amplitude

DIFFERENTIAL INPUT VOLTAGE (V) Figure 13. Total Jitter as a Function of Input Amplitude

0.70

 $V_{ICM} = 2.4V$

0.85

1.00

Product Folder Links: DS10BR150



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REVISION HISTORY

Ch	changes from Revision C (April 2013) to Revision D	
•	Changed layout of National Data Sheet to TI format	9

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PACKAGING INFORMATION

Orderable part number	Status	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
DS10BR150TSD/NOPB	Active	Production	WSON (NGQ) 8	1000 SMALL T&R	Yes	SN	Level-3-260C-168 HR	-40 to 85	1R150
DS10BR150TSD/NOPB.A	Active	Production	WSON (NGQ) 8	1000 SMALL T&R	Yes	SN	Level-3-260C-168 HR	-40 to 85	1R150

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

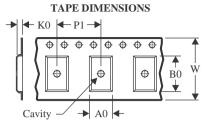
⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

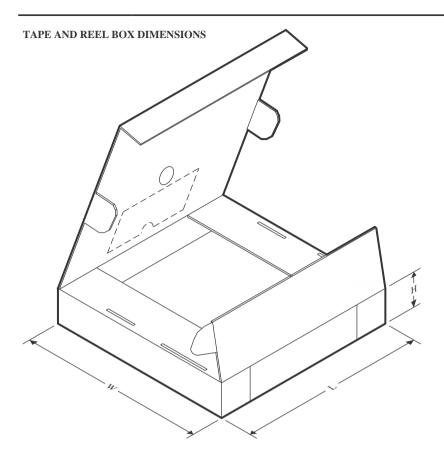


*All dimensions are nominal

Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS10BR150TSD/NOPB	WSON	NGQ	8	1000	177.8	12.4	3.3	3.3	1.0	8.0	12.0	Q1

PACKAGE MATERIALS INFORMATION

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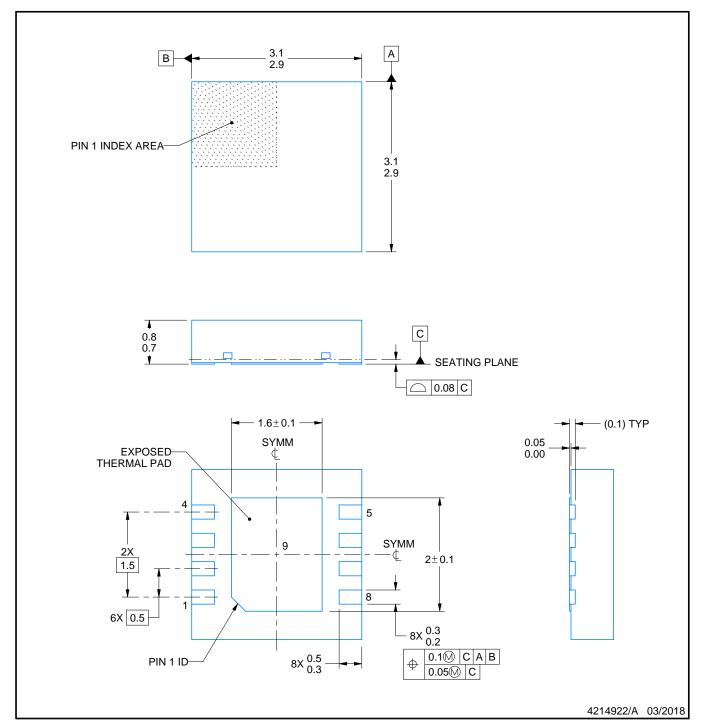


*All dimensions are nominal

	Device Package Type		Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
I	DS10BR150TSD/NOPB	WSON	NGQ	8	1000	208.0	191.0	35.0	



PLASTIC SMALL OUTLINE - NO LEAD



NOTES:

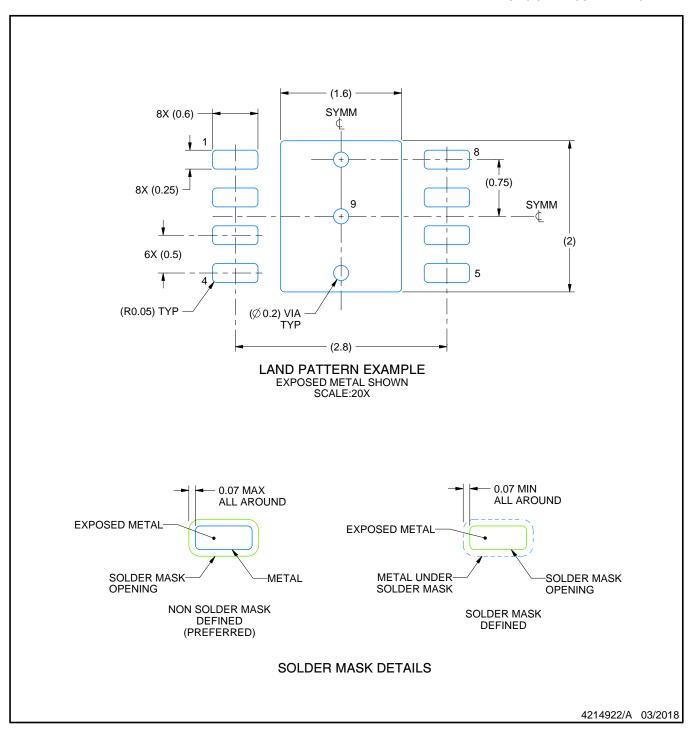
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



PLASTIC SMALL OUTLINE - NO LEAD

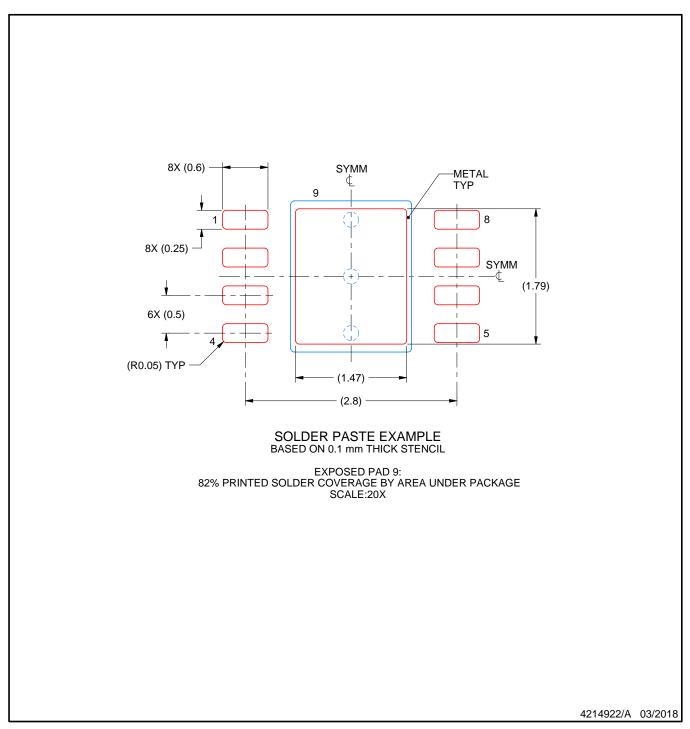


NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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Last updated 10/2025